

<b>Notice of References Cited</b>	Application/Control No. 09/760,434	Applicant(s)/Patent Under Reexamination JOSEPH ET AL.	
	Examiner Michael R Vaughan	Art Unit 2131	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2001/0056503 A	12-2001	Hibbard, Richard J.	709/250
	B	US-6,006,259	12-1999	Adelman et al.	709/223
	C	US-6,275,860	08-2001	DeForest et al.	709/230
	D	US-6,438,612	08-2002	Ylonen et al.	709/249
	E	US-6,055,236	04-2000	Nessett et al.	370/389
	F	US-5,473,599	12-1995	Li et al.	370/219
	G	US-5,151,899	09-1992	Thomas et al.	370/394
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 200062507 A1	10-2000	World Intellect	MEDVINSKY, S	H04L 29/06
	O	JP 2003115834 A	04-2003	Japan	TOKINIWA et al.	H04L 09/08
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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